PROJECT FINAL REPORT

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Project acronym: 20plµs

Project title: "20 percent efficiency on less than 100 µm thick industrially feasible c-Si

solar cells"

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4.1 Final publishable summary report

• Executive summary

The reduction of cost per Watt-peak (W_p) for silicon solar cells is most efficiently achieved by reducing silicon material cost using thin wafers *and* by enhancing efficiency to above 20%. However today's industrial standard cell structures are not suited to reach this goal. Additionally, the mechanical yield of the solar cell and module production has to be high enough to reach cost effectiveness, which tends to be in contradiction with wafer thickness reduction. The 20plµs project aimed to resolve this contradiction for a solar cell thickness of 100 µm at a solar cell conversion efficiency of above 20%.

The overall objective of this project was the development of a 20% efficient silicon solar cell with a thickness below 100 μ m and realizing a conversion efficiency of 19.5% on thin solar cells of a thickness of 100 μ m with an area of 156 x 156 mm² in a pilot production line in the second half of the project duration. A process was developed and transferred to the *industrial pilot production line* of Hanwha Q CELLS. The result of the 100 μ m thin cell fabrication is a *median cell efficiency of 20%* The best cell has an efficiency of 20.3 %. With process and handling adjustments a breakage rate of 4.5 % is achieved at the pilot line of Hanwha Q CELLS.

Cost and lifecycle analysis of the three process routes considered in the 20plµs project were carried out by ENI.

A dissemination work shop took place on Wednesday 24th of April at the Chambery Conference Centre Le Manage with the title "Industrially feasible processes for the next generation of high efficiency and thin crystalline silicon solar cells". This specific industry-oriented workshop was opened to the public and addressed the photovoltaic professionals. During the workshop the major 20plus EU-project results were presented. Also, external speakers were invited at the workshop.

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• Summary description of project context and objectives

The reduction of cost per Watt-peak (W_p) for silicon solar cells is most efficiently achieved by reducing silicon material cost using thin wafers *and* by enhancing efficiency to above 20%. However the industrial standard cell structures available at project start were not suited to reach this goal. Additionally, the mechanical yield of the solar cell and module production had to be high enough to reach cost effectiveness, which tends to be in contradiction with wafer thickness reduction. The 20plµs project aimed to resolve this contradiction for a solar cell thickness of 100 µm at a solar cell conversion efficiency of above 20%.

The overall objective of this project was the development of a 20% efficient silicon solar cell with a thickness below 100 μ m. The process was to be transferred to a pilot line at an industrial partner aiming at a yield that is comparable to the one in standard production and realizing a conversion efficiency of 19.5% on thin solar cells of a thickness of 100 μ m with an area of 156 x 156 mm² in the second half of the project duration.

The project dealt with the full process flow, addressing the following topics which are particularly crucial for solar cells on thin wafers, in more detail: wafering, surface passivation, light trapping, solar cell and module processing and handling of the thin wafers.

Three basic process routes were followed which are categorized by the emitter formation temperature and the base material doping type i. e. p-type Si and n-type Si with high temperature - pht and nht - and n-type Si with low temperature emitter - nlt -. Schematics of these solar cell designs are given in Figure 1.

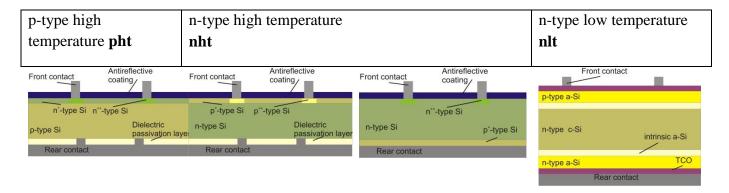


Figure 1: The general cell types developed within the project

The specific objectives of the project are explained in the following.

- The *wafering* of the Si ingots was performed by the established wire sawing process however using advanced technologies like diamond saw wires. The handling from the ingot to the process-ready wafer was investigated. The mechanical stability of the wafers was optimized applying different wet-chemical treatments. Breakage tests were carried out, assessing the impact of sawing and etching parameters on wafer strength. The target was to show a yield as high as that of standard wafering, but at lower thickness.
- When the wafers become thinner *surface passivation* becomes crucial, because more and more minority charge carriers reach a surface and their recombination needs to be reduced. Within the consortium, all passivation techniques currently under investigation within the PV

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community were available. Therefore we aimed at the most suitable passivation layer with regard to deposition method and physical properties for each solar cell type according to Figure 1.

- Because of the indirect bandgap of Si, the part of the infrared light absorbed within the
 wavelength range of 900 to 1200 nm decreases with decreasing wafer thickness. The
 objective was to quantify and validate device structures allowing the best optical approaches
 for minimizing current losses, which are otherwise unavoidable because of the wafer
 thickness reduction. Advanced light trapping schemes were subsequently implemented into
 the solar cell concept.
- Solar cell processes according to Figure 1 were evaluated taking into account industrial feasibility and thus the time to bring the process into production as well as the efficiency potential. The evaluation was supported by the consortium's wide range of characterization methods. The main objective here was to find the best compromise between light trapping, surface passivation, emitter design, metallization, bulk lifetime, bulk resistance and handling. In particular, the selective emitter and the heteroemitter approach was to be investigated. Mechanically low-impact metallization techniques were evaluated like metal jet printing and plating. The solar cell process was adapted to different material qualities like those shown by mono- and multicrystalline Si wafers. In addition the further processing of the cells to modules was demonstrated.
- The *handling* of very thin and ultra-thin thin wafers shows some differences. While the 100 µm wafers can still be handled in an adapted standard way the wafers of a thickness of around 50 µm might need a support and are handled preferably horizontally. A feasible handling system for each category was to be defined and tested. A throughput of 1500 wafers/h for a handling step should be demonstrated.
- A step/iterative/comparative process in order to evaluate and describe the three new cell
 processes was followed to define a set of parameters needed to structure the life cycle
 analysis and cost model and to identify the most sustainable scenario from the technicalsocio-environmental-economic point of view. The assessment included cost evaluations and
 scalability issues.

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• Main S&T results

In the following section the results of the project are presented in the context of work packages. The work was divided in 10 work packages along the solar cell process chain namely, WP1: Wafering and handling, WP2: Bulk properties, WP3: Emitter formation, WP4: Surface passivation, WP5: Light trapping structure, WP6: Metallization, WP7: Prototype cells, WP8: Integration of new processing steps into complete processes and fabrication of demonstration modules, WP9: Assessment and Dissemination. WP10 dealt with the project management.

Work package 1 "Wafering and Handling"

The activities of WP1 lay the foundation for the use of thin wafers in the following process sequences. The stability and yield of the subsequent process and handling steps depend on the wafer quality and the reduction of micro-cracks serving as starting points for cracks and thus wafer breakage. The development of a suitable cutting process including pre-processing of bricks with minimizing micro-crack formation and post-processing in form of wafer separation and wafer cleaning is the focus of the first two tasks within WP1. In most of the following steps of solar cell processing, the wafers are exposed to mechanical stress e.g. during printing, metallization and wet bench processing or thermal stress e.g. during diffusion or firing processes. The wafer manipulation between these steps represents a second type of load on the wafers. The adaption of these processes and a comprehensive optimization of wafer handling has also been worked on in WP1.

The actual industrial standard wafering process is optimized for the production of wafers with a thickness of 160 - $180 \,\mu m$. To cut thinner wafers the pitch of the wire guidance rolls can easily be adjusted as a first step. However, the main challenge for cutting thin wafers below $100 \,\mu m$ thickness is a comparable wafer quality and yield. The experimentally cut wafers were characterised for thickness, roughness, sawing marks and partially for breaking behaviour.

Slurry sawn wafers typically show a wedge shape because the active silicon carbide (SiC) particle diameter dominating the material removal changes along the sawing channel due to breakage or drainage of the particles. The sawn wafer surface is dominated by brittle material removal which consists of stochastical indentations of SiC particles. In **Figure 2**, left, a three dimensional thickness mapping of such a wafer with a nominal thickness of $110 \, \mu m$ is shown.

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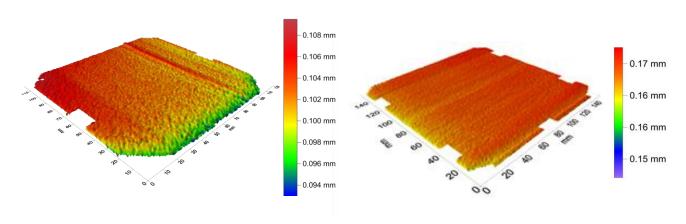


Figure 2: Left: Thickness mapping of an as cut 110 µm thick wafer using straight wire. Right: Example of the thickness mapping of a monocrystalline wafer cut with structured wire.

Wafer surfaces using structured wires show characteristic properties of diamond and straight wire sawn surfaces, compare to **Figure 2**, right. The surface structure suggests that a hybrid brittle-ductile material removal process is active when using structured wires. SiC particle indentations are visible without the typical wedge shape of standard slurry sawn wafers. Furthermore, the total thickness variation (TTV) values are reduced by about 50% for different combinations of wire velocity and feed rate which is especially essential for thin wafers. Therefore, a future task will be the process development for cutting of thin wafers by structured wire.

Work package 2 "Bulk properties"

The aim of the project is to develop high efficiency solar cell processes for mono- and multicrystalline Si. Therefore the selection of the most suitable material for each solar cell category as defined in Figure I has to be done for mono- as well as for multicrystalline Si. The evaluation of p-type versus n-type doping of the Si material is a key issue.

This WP is concerned with the evaluation of the doping type used with mono- or multicrystalline Si that is most suitable for the process transfer into the pilot production line as well as the achievement of highest efficiencies. In addition, the interaction between material properties and solar cell process was studied.

The 20plµs project dealt with mono and multicrystalline p-type Si and monocrystalline n-type Si, which was purchased for the consortium at the beginning of the project.

For the boron doped p-type mono-Si BO related degradation was investigated. A smaller V_{OC} degradation of 100 μ m thin wafers compared to 180 μ m thick wafers was determined for the thinner ones. 2dimensional simulation were carried out showing the dependence of the efficiency on doping

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concentration and wafer thickness. Thermal donors did not influence the properties of neither boron nor gallium doped Si.

The ELBA [1] method was applied to determine the material limited efficiency of the boron doped p-type Si material purchased. Spatially resolved efficiencies could have been determined. The boron doped monocrystalline Si material allowed to reach the final goal of 20% efficient 100 μ m thick solar cells.

For n-type solar cells the optimum doping concentration for the PHOSTOP [2] cell concept was studied. The higher the base doping concentration, the smaller the optimal thickness of the Si substrate and the sharper the optimum, which the reduced diffusion length caused by an increased doping concentration accounts for.

For the low temperature approach the ideal wafer base resistivity was found to be between 1 and 5 Ω cm. Concerning the wafer thickness W, the passivation level can be maintained with the same a-Si:H layers by reducing W. But thanks to the reduction of W, the injection level corresponding to 1 sun is shifted to higher values. As a consequence, the implied V_{oc} of the cell precursor and also the real V_{oc} of the finished cell is increased.

All Si material purchased in the 20plus underwent thorough process monitoring.

Work package 3 "Emitter formation"

This WP deals with the investigation of high temperature emitters in the advanced homogeneous emitter and the selective emitter design formed by high temperature diffusions from POCl₃ and BBr₃. The low temperature emitter is carried out as a heteroemitter based on amorphous Si. Besides the development of these processes each process is evaluated with regard to process complexity and efficiency potential.

The high temperature emitters were optimized with regard to a low emitter saturation current, the possibility to passivate them very well with industrially feasible means and to contact them with a low contact resistance.

Due to the kink and tail profile of the P-diffused Si a selective emitter etch back is a favorable way to reach lowly recombinative emitters. An etched back high temperature phosphorous emitter with less than 20 fA/cm² was demonstrated. A homogeneously diffused emitter without etch back showed a saturation current of less than 100 fA/cm².

For n-type Si wafer boron and aluminium emitters were investigated. Since the B emitter does not show a kink and tail, already as diffused emitter of $100~\Omega/\text{sq}$ showed saturations currents below $20~\text{fA/cm}^2$ on a planar surface passivated with Al_2O_3 . The textured surface shows only a slightly enhanced saturation current of about $30~\text{fA/cm}^2$. Contact resistivities of less than $2~\text{m}\Omega\text{cm}^2$ and less than $4~\text{m}\Omega\text{cm}^2$ for $50~\text{and}~100~\Omega/\text{sq}$ high temperature boron emitters respectively were achieved with screen-printed paste.

Al doped emitters have been formed using Al-paste. The back junction solar cells showed a V_{OC} of 651 mV. The large bow of these solar cells was removed by applying the procedure from Huster [1=3] i.e. cooling the solar cell down to values well below 0°C and subsequently the cells are flat at room temperature.

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The low temperature emitter based on amorphous Si is responsible on the solar cell front surface for significant parasitic absorption. The focus was put on the development of high quality passivation layers, giving high carrier lifetimes already in the as-deposited state and with minimal thicknesses. This allowed to achieve a V_{OC} of 747 mV determined on 97 μ m thin nlt solar cell.

Work package 4 "Surface passivation"

The crystalline silicon wafers which are used as substrate for the fabrication of solar cells are almost perfect crystals. This perfection is giving to crystalline Si its incredible propriety that allows the conversion of suns light into electricity. However this perfection stops on the surface of the wafer, which gives to the surface very poor electrical properties. As the thickness of the substrate is decreasing the surface to bulk ratio increases and with it the effect of the surfaces. In order to fabricate high efficiency Si solar cells a very good surface passivation is needed, this is true for thick solar cells but even more crucial for very thin wafers. In this project, several types of passivation layers were developed:

- a-Si passivation layers were developed for the fabrication of heterojunction solar cell (nlt). These layers provide a very high passivation quality allowing surface recombination velocity bellow 10 cm s⁻¹. A deposition method known as "layer by layer deposition" was used in order to achieve the highest passivation quality while keeping the film thickness very low (< 10 nm). The excellent passivation quality allowed to obtain V_{oc} up to 747 mV on very thin wafers.
- For *p*-type wafers processed at high temperature (pht), the front surface passivation used was SiO₂ SiN_x stacks or simply a SiN_x layer. The rear surface passivation was provided by Al₂O₃ SiN_x stack, which is an excellent passivation solution for lowly doped *p*-type surfaces. These layers could provide a passivation quality allowing surface recombination velocity bellow 10 cm s⁻¹ even after a fast high temperature contact sintering (firing) which is perform at a temperature above 800°C for a few seconds. A great focus was put on a deposition method that allows the pilot line production of solar cells. The Al₂O₃ layers were deposited using an inline PECVD system. The process on this tool was shown to be homogenous and repeatable. For this solar cell concept, a solar cell efficiency of 19.9% was obtained on 103 μm thin wafer, with a V_{oc} of 672 mV. The internal quantum efficiency's (IQE) shape testify the very high rear passivation quality.
- For *n*-type wafers processed at high temperature (nht), the surface passivation of the *n*-type doped surface (front or back surface field) was realised by SiO₂/SiN_x stacks or a simple SiN_x layer. The boron emitter was passivated by Al₂O₃ SiN_x stack, which provides a very high passivation quality. Very low emitter saturation current density of about 36 fA/cm² was reach on a 90 Ω/sq. emitter. It was calculated, that this value corresponds to a surface recombination velocity of about 340 ± 20 cm s⁻¹ for a surface doping concentration of 7 × 10¹⁹ cm⁻³ which is more than one order of magnitude lower than for SiO₂. It is important to point out that this excellent result was not only obtained only for ALD Al₂O₃ layers but also for PECVD Al₂O₃ layers, which can be used in a pilot production line.

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The passivation of the surface is very important however it cannot be developed independently from the other solar cell processes and requirement. The surface passivation is usually obtained by depositing a layer on the surface of the wafer or by growing a SiO_2 layer, which affect the optics of the solar cell. Therefore the development of the passivation layer needs to be done in line with the light trapping. Here the focus was put on the rear internal reflection properties provided by rear passivation stacks. It was obtained that the stacks composed of a thin Al_2O_3 layer covered by a SiN_x layer can provide a rear internal reflectance of 90%, without compromising the passivation quality or the possibility of forming a contact.

The post-passivation steps should be also taken into account in the development of the passivation concept. More especially during the metallisation step, in the case of Ni plating in the front contact, the front dielectrics is playing the role of a masking layer. As Ni deposit on all non-covered Si surfaces the front surface passivation need to be very dense. Here the best results were obtained using LPCVD SiN_x . The metallisation often mean also, a high temperature step that might destroy the passivation quality. For this reason, the Al_2O_3 SiN_x passivation solution was developed to be resistant to firing process, and was also found to resist against attacks of Al during firing processes.

During the project a passivation competition was organised between four partners. As shown in Figure 3 all the partners went very close and all of them obtained a lifetime ranging 2 ms on a p-type 1 Ω cm FZ-Si substrate. In other words, an excellent passivation quality was obtained by the four participants.

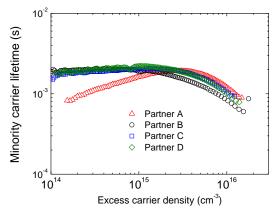


Figure 3: Minority carrier lifetime as a function of the excess carrier density.

Work package 5 "Light trapping structure"

The overall objective of WP05 is to maintain high short-circuit current (J_{sc}) as the wafer thickness is decreased to less than 100 μ m. WP05 is broken into three tasks, and we present here summaries of the results of each task.

Task 5.1 was concerned with the development and assessment of new materials and material stacks with superior optical performance. Much of the work within this task was focused on the rear reflector materials stack, since it is a significant source of parasitic absorption in all three cell types (pht, nht, and nlt). For high-temperature cells, silicon oxide/silicon nitride/aluminum ($SiO_2/SiN_x/Al$)

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and aluminum oxide $(Al_2O_3)/SiN_x/Al$ reflectors were investigated experimentally and theoretically as a function of the dielectric layer thicknesses, and reflectances above 90% were achieved at 1200 nm for optimized stacks on wafers with polished front surfaces, indicating low parasitic absorption. For nlt solar cells, a new, high-mobility transparent conductive oxide (TCO) material—hydrogenated indium oxide—was developed and demonstrated to increase long-wavelength quantum efficiency—and thus J_{sc} —because of its reduced free-carrier absorption [3]. In addition, a thorough analysis of the parasitic absorption in the front TCO/amorphous silicon (a-Si) stack of nlt solar cells (these layers and their associated absorption are absent in nht and pht cells) was performed experimentally with complementary modelling [4]. Optimization of the a-Si layer thicknesses and TCO allowed us to achieve a 2 mA/cm² gain in J_{sc} . Also, starting with the external quantum efficiency (EQE) and reflectance (R) spectra measured on our best 100- μ m-thick nlt cell, we showed several ways in which these spectra may be modified to boost $J_{sc,active}$ to 41 mA/cm². The three possible routes to improvement are decreased UV parasitic absorption, improved internal reflection, and improved light trapping. We showed that the first route is the most effective and that extending the path length of IR light is not the only way to high currents.

Task 5.2 focused on assessing the effects of various light trapping schemes, and in particular, examining the role of surface texture. For monocrystalline wafers, a side-by-side comparison was performed for alkaline (pyramids), acidic (craters), and plasma (nanostructures) textures. With an Al₂O₃/SiN_x/Al rear reflector stack developed in Task 5.1, we demonstrated that the surface texture greatly influences the long-wavelength reflection (and therefore J_{sc}), indicating that either the front reflectance or parasitic absorption in the Al layer may be sensitive to texture [5]. For multicrystalline Si wafers, a honeycomb texture achieved by mass-production-compatible nano-imprint lithography was developed. Tests on wafers of various thicknesses resulted in no breakage for wafers as thin as 100 µm, and the new honeycomb texture often outperformed the standard multicrystalline acidic "isotexture" in reflectance measurements. We reported that IR parasitic absorption in silicon heterojunction solar cells arises from free-carrier absorption in both the front and rear TCO layers, as well as plasmonic absorption in the rear metal electrode [6,7]. The plasmonic loss occurs only for ppolarized light that is incident on the rear TCO above the critical angle, and only if the metal electrode is within the penetration depth of the resulting evanescent wave. Consequently, one method to mitigate the loss in the metal electrode is to require the rear TCO layer to play an optical as well as electrical role by making it thick and very transparent. An alternative approach is to make the rear TCO very thin so that it serves only an electrical contact function (or dispose of it altogether if a suitable doped a-Si:H/metal junction can be formed), and to add another layer specifically to suppress plasmon excitation in the metal electrode. An MgF₂/Ag reflector was demonstrated to yield an average rear internal reflectance of greater than 99.5% and an infrared internal quantum efficiency that exceeds that of the world-record UNSW PERL cell [8]. Local contacts through the insulating MgF₂ layer are necessary to collect electrons at the rear of the cell. However, the contact design requirements are relaxed compared to those for PERL-like solar cells because these local contacts are through an optical—not passivation—layer. With such as rear structure an active area short circuit current density > 42 mA.cm⁻² is feasible for nlt-type cells.

The goal of *Task 5.3* was to evaluate the impact on device performance of the new materials and light-trapping schemes developed in Tasks 5.1 and 5.2. This analysis has both experimental and

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theoretical components: EQE and reflectance measurements are used to evaluate the gains and losses in J_{sc} as new materials, stacks, and textures are developed and integrated, while modelling is employed to predict the performance of new structures in final devices. A rigorous coupled wave analysis (RCWA) optical simulation of a cell with a SiO₂ rear diffraction grating was carried out for variable grating period and depth. For a textured front surface, a J_{sc} gain of 0.2–0.7 mA/cm² is predicted for an optimized grating compared to a planar rear surface. For nlt cells, we have performed a complete experimental analysis of all J_{SC} losses in a high-efficiency (>20%) cell 96 μ m thick. Active-area and aperture-area J_{SC} were measured and compared to reveal that 6% of light is reflected from the front silver grid, corresponding to a J_{SC} loss of 2.2 mA/cm². EQE and reflection measurements showed that 1.1 mA/cm² is lost because of reflection from the front wafer surface, 1.5 mA/cm² remains to be gained by eliminating parasitic absorption in the front a-Si layers, 1.1 mA/cm² is lost because of parasitic absorption in the TCO and rear metal reflector, and 0.6 mA/cm² can be gained by improving light trapping. This analysis provides a clear path to further improvement of J_{SC} in thin nlt cells, as required by WP05.

Besides, losses of maximum 2 mA/cm² on 70 μ m thick nlt cells compared to standard thickness were demonstrated. Table 1 compares nlt solar cells made from wafers with different thicknesses, but the same a-Si:H layers and TCOs have been used on both devices. We see that even with a drastic reduction of wafer thickness down to 70 micron, we still can maintain a high short circuit current density, where a J_{sc} loss $< 2mA/cm^2$ is achieved.

	FZ 250 μm 4 cm ²	Cz 70 μm 4 cm ²
V _{oc} [mV]	726	747
J _{sc} [mA/cm ²]	38.1	36.9
FF [%]	77.0	77.9
Efficiency [%]	22.3	21.5

Table 1: Solar cell characteristics of a 70 μm-thick wafer compared to standard 250 μm-thick device.

Work package 6 "Metallization"

The metallization of very thin and ultra-thin Si wafers requires careful selection of an appropriate metallization process. The compatibility of the metallization process with the properties of the surface passivation layer must be considered. Owing to the difference between the thermal expansion coefficients of the metal and Si, the mechanical impact of the metallization must also be taken into account

The key objectives of WP06 were to develop non-contact and/or low temperature technologies to

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avoid thermal and mechanical stresses on thin wafers, to minimize current losses due to shading by employing front contact finger widths $\leq 50 \, \mu m$, and to minimise series resistance through the optimization of contact geometry and the use of advanced metallization technologies capable of achieving line resistance $\leq 0.3 \, \Omega/\text{cm}$ and contact resistivity values $\leq 2 \, \text{m}\Omega/\text{cm}^2$.

The output from this WP resulted in several scientific achievements and the successful delivery of key deliverables and milestones. Front contacts less than 50 μ m (35 μ m) wide were produced with gridline resistance of less than 0.3 Ω /cm (0.21 Ω /cm). A robust two-step Ni plating process electroplated with Cu was achieved resulting in line resistance < 0.3 Ω /cm and linewidth ~ 65 μ m.

A 100 μ m thick LGBC/LFC solar cell demonstrating increased IQE at longer wavelengths was demonstrated. However, LGBC were not recommend for the processing of 100 μ m thick cells, since LGBC front contacts compromised the mechanical stability of the wafer. A process combining aerosol jet printing and LIP has been demonstrated on standard thickness cells resulting in efficiencies of 20.3 % on 4 cm². A metallisation process combining electroless Ni and Cu LIP has also been developed. Screen printing with low temperature paste has been successfully demonstrated on 96 μ m n-type low temperature (nlt) process cells (Efficiencies of 20.8 % on 4 cm²). A gain of over 3 mA/cm² was demonstrated by improved light confinement for 100 μ m on nlt cells. Finally, a 20.3% efficient 100 μ m thick screen printed solar cells were demonstrated on a pilot production line facility.

Work package 7 "Prototype cells"

Prototype solar cells integrating the individual processing steps from work packages 1 to 6 are developed in this WP.

Starting the development on $100 \, \mu m$ thin p-type boron doped Cz-Si solar cell full area screen-printing was applied forming the BSF and the base contact. On the front a selective emitter was applied which was passivated by an oxide nitride stack. With this concept an efficiency of 18.7% with a V_{OC} of $645 \, mV$, a J_{SC} of $36.6 \, mA/cm^2$ and a FF of 79.3% was achieved.

After optimising front emitter and rear local contact properties an independently confirmed efficiency of 19.9 % for the best thin PERC solar cell, fabricated on 0.5 Ω cm boron-doped p-type silicon material was demonstrated. The other cell parameters are a high V_{OC} of 672 mV, a J_{SC} of 38.5 mA/cm² and a FF of 76.8%. An area-averaged cell thickness of 103 μ m was determined via weight measurement. This cell concept has been realised without any alignment steps during manufacturing.

A first set of 100 μ m thin mc-Si solar cells with dielectric rear passivation and laser fired Al contacts were manufactured. The front emitter on an acidic texture was passivated by a SiN layer and the base at the back by a stack of Al₂O₃ and SiN. Front contacts were silver screen-printed and the rear metal was evaporated on the full area. Rear contacts were formed by the LFC method. An efficiency of 16.9% was achieved. The other cell parameters are a high V_{OC} of 625 mV, a J_{SC} of 35.4 mA/cm² and a FF of 76.2%. A second set of mc-Si solar cells showed efficiencies up to 17.1%. The efficiencies were mainly limited by the bulk lifetime of the Si wafer.

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Using thin n-type Si wafers, Al rear emitter solar cells of 100 μ m with homogeneous and selective emitter were fabricated. The Al emitter was full area contacted by the Al metal paste. The front surface field was passivated by a stack of thermal oxide and SiN. The cell had a size of 125 x 125 mm², the base resistivity was 2.8 Ω cm. The solar cells with selective FSF achieved efficiencies of up to $\eta = 19.0\%$ compared to the homogeneous FSF samples with $\eta = 18.0\%$.

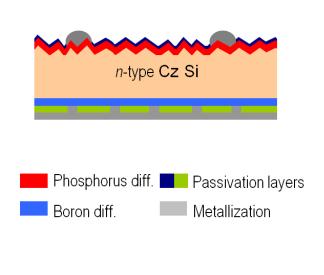
Applying the low temperature emitter to fabricate a Si heterojunction solar cell an only 70 μ m thin cell with an efficiency of 21.7% was demonstrated. The V_{OC} was as high as 747 mV and the J_{SC} and FF were at 37.5 mA/cm² and 77.8% respectively.

Work package 8 "Integration of new processing steps into complete processes and fabrication of demonstration modules"

The objective is the transfer of the developed processes to an industrial-type setting and demonstration of pilot production of very thin cells ($100 \, \mu m$ thick) at an efficiency of 19.5% on $156 \, x \, 156 \, mm^2$ large area wafers and manufacturing of a demonstration module. WP8 assembles the suggested preferred processes for each step from WP1 to 7.

The decision for the solar cell process for the pilot production line is made in MS30 as the starting point for transfer of the process from research lab-type setting to an industrial-type setting. The pht process with the additional processing steps rear passivation and LFC compared to the standard screen printed reference process is the less complex process to realize. The nht process is chosen as a backup in MS30. It has a higher efficiency potential than pht but a more complex development is required. A nlt process has the highest efficiency potential, but is the least developed technology. Therefore the development timeline in an industrial-type setting at HQC of a nlt process was too long for the scope of the project.

Nht (<i>n</i> -type high temperature)
Single side alkaline texture
BBr3 diffusion
BSG removal
Front ARC
Single side emitter removal
POCI3 diffusion rear
PSG removal
PECVD SiN rear
Front contacts screen-printing Ag/Al
Drying
Firing in a belt furnace
Laser opening of SiN
Physical vapor deposition of Al



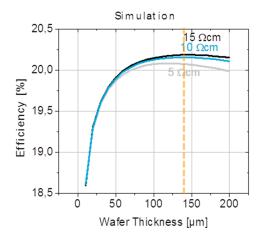
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Figure 4: Baseline process for mono-crystalline n-type Si front junction solar cells of the high temperature route, suggested by the project (left). A double-side contacted back junction solar cell is the modified nht cell for HQC pilot line production (right).

In D08.1 the cell processes from WP1 to WP7 are integrated into complete pilot line high efficiency cell processes of pht and nht. Large area cells with 200 μ m thickness are fabricated to prove the feasibility of the process routes. Nht showed higher cell efficiencies than pht. In a first fabrication lot the nht route of Figure 4 left achieved a median cell efficiency of 19.7 %. Process flow was still with additional thermal SiO₂ as diffusion barriers, to make sure that both diffusions are separated. To adapt cells to feasible mass production the nht route is then modified in D08.2 to a back junction cell route [9]. With this modified nht route a complete ingot can be used [10]. The n-type ingot distribution is industrially feasible for ingots > 5 Ω cm. From 2 to 5 Ω cm: the passivation quality of the front side n^+ -n junction improves with increasing bulk resistivity [11], therefore J_{sc} and η increase strongly. Efficiencies up to 20.9 % (5.1 W) on 6" back junction cells are reached after further improvement of passivation and metallization.

For saving Si material the influence of wafer thickness is estimated by PC1D simulation in D08.2 (Figure 5 left) [12, 13]. The outcome of the simulation is: the back junction cell concept is suitable for 100 to 200 μ m thick wafers. There is freedom of choice, adaption to wafer market situation is possible.

In D8.3 the high efficiency cells of the pilot line are successfully integrated into a 60 cell module produced with modified nht from 200 μ m thick wafers. With cells of 19.6 to 20 % cell efficiency a module of 278 W is produced.



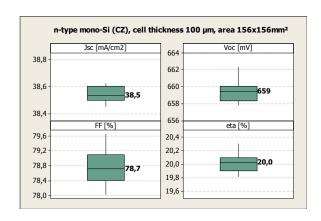


Figure 5: Left: simulated influence of wafer thickness on back junction solar cell. Cell concept is suitable for 100 to 200 μm thick wafers. Right: result of 100 μm thin cell fabrication is a median cell efficiency of 20 %.

Finally in D08.5, D08.6 and MS37, the high efficiency process steps of D08.2 and handling are adjusted to thin wafers to arrive at the project goal of a high efficiency cell production with thin wafers with total breakage rates < 5 %. Diamond wire sawn wafers are used, because of their better

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total thickness variation compared to slurry sawn wafers. The metallization process generates most mechanical stress and bowing of wafers. Therefore the bus bars are printed rectangular to the sawing grooves taking advantage of the higher stability of diamond wire sawn wafers rectangular to the sawing grooves. Completely processed solar cells with thickness of 100 µm show a 3 mm bow. During transfer of wafers from carrier to belt the thin wafers with bow stick together. To avoid this, the carrier height has to be corrected. Furthermore, drying air stream after printing, firing temperature, and soldering conditions are adjusted to the thin cells. With process and handling adjustments a breakage rate of 4.5 % is achieved, tested with 100 µm thin cells processed with modified nht at the pilot line of Hanwha Q CELLS. The simulated influence of wafer thickness is confirmed by the fabricated cells of 100 µm thickness. Thinner cells show a current loss, which fits to an IQE loss for long wavelengths. The result of the 100 µm thin cell fabrication is a median cell efficiency of 20 % (Figure 2 right). The best cell has an efficiency of 20.3 %. With this result D08.6 and the project goal of 19.5 % cell production efficiency of 100 µm thin, 156 x 156 mm² large area cells is successfully demonstrated in the pilot line of Hanwha Q CELLS.

Work package 9 "Assessment and Dissemination"

Work Package 9 takes into account assessment and dissemination activities. Three different process cells are proposed within the project and referred to as pht, nht and nlt routes. Each of those is an industrial feasible process targeted to achieve high cell efficiencies on thin wafers.

The assessment phase consisted of comparing the process flows to establish the maturity of each technology and its relating readiness for a pilot line production transfer. The evaluation was not limited at the scaling up angle, but focused to take into account potentiality of each technologies with spotlight on beneficial/detrimental aspects. In this regard, environmental impacts were assessed and manufacturing costs calculated.

The dissemination activity consisted of organizing a dissemination workshop, focused on presenting the major results achieved during the project.

Assessment phase

Process scale-up

The first decisional aspect involved the transfer of the processes from lab scale to pilot line production. Particular attention was paid to the following issues: efficiency potential, availability of industrial equipment, process complexity, process compatibility with thin substrates (induced mechanical stresses), module integration, intellectual properties and possible additional processing costs. The pht route was found to be the most feasible process for pilot line production implementation; the nht route was kept as alternative backup process.

Cost analysis

The cost analysis consisted of calculating the Cost of Ownership (CoO) for all the three 20plµs processes (pht, nht and nlt). It was developed in three stages.

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In the CoO calculation the following expenses were considered: operating costs (supply of raw materials, utilities and consumable parts), as well as construction of the buildings (e.g. for production, offices...), equipment purchase, facility/utility/storage, labour, maintenance and quality loss (mechanical, optical and electrical yield losses) costs.

Wafers were supposed to be purchased.

In the first two stages, the CoO was calculated for a cell fab located in the EU and with 60 MWp yearly capacity and 20plµs routes were compared one with the other. The pht route turned out to be the most cost effective technology.

In the third stage, the CoO was calculated for mass production in Asia of pht cells. Costs were calculated assuming economy of scale. A comparison with the reference process was carried out. It turned out that the pht route could achieve a total cost reduction in the range of 24-28%, such range depending on process yield optimization.

Life Cycle Assessment

Environmental performances of 20plµs processes were calculated by means of LCA analysis. The EDIP methodology was applied to assess the impacts. The analysis is carried out in three different steps.

In the first calculation, the analysis was focused on cell manufacturing, neglecting treatment of waste waters. In the second calculation, data was refined and waste water treatment was included in the simulation. It turned out that PECVD and metallization steps play a relevant role in the impacts. As for PECVD, the exhaust gases require appropriate cleaning, with resulting negative effect on impacts due especially to fossil fuel use in the cleaning process. Also metallization represents a critical process, independently of the specific technology used to apply the electrodes onto the cells. Impacts are caused by precious metals use.

In the third run, data was further refined and system boundaries were extended to include the production of thin wafers. Impacts of 20plµs routes were compared with reference technology (for the reference process, the production of c-Si wafers with standard thickness was considered). It was found that, category by category, significant improvements can be reached when thin wafers are used. In fact, impacts related to 20plµs routes are always lower than the reference's ones, with the exception of photochemical oxidation.

Additionally, systems boundaries were extended to include also the assembly of cells into modules, BOS and installation of PV-systems on rooftop. Carbon Footprint and Energy PayBack Time, which are typical environmental performance indicators of PV-systems, were calculated for 20plus-technology applying PV-systems and compared with those of the reference case. A significant drop-down in Carbon Footprint and EPBT values was found for 20plus PV-systems.

Dissemination

The "20plus Dissemination Workshop" took place on Wednesday 24th of April at the Chambery Conference Centre Le Manage with the title "Industrially feasible processes for the next generation of high efficiency and thin crystalline silicon solar cells". This specific industry-oriented workshop was opened to the public and addressed the photovoltaic professionals. During the workshop the

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major 20plus EU-project results were presented. Also, external speakers were invited at the workshop.

Work package 10 "Project management"

All project management was organized in this work package. UKON was responsible for the overall coordination. PSE provided support for administrative management tasks.

The main objectives were:

- Enable a smooth flow of the project
- Ensure well timed reporting to the European Commission

Results:

Day-to-day management of the project

Management of Deliverables and Milestones

Meetings organized

Minutes drafted and completed

Website updated

Intellectual Property Rights management

Amendment to the contract implemented when there were changes in the Consortium (three major changes at the consortium partners in three years)

Financial management: Collection and compilation of cost details and justifications

Periodic and final reporting done

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• Potential impact and the main dissemination activities and exploitation of results S&T results

Within the 20plus project significant attention was paid to socio-environmental-economic aspects.

First of all the 20plµs technology was analyzed from the technological point of view and the scalability to pilot line production was assessed. All the aspects can act as driving force in the lowering of the PV-generated kWh cost and ultimately target the spread out of PV-systems to reach a broader distributed electricity generation scenario in the EU.

On the environmental side, a life cycle analysis was performed to assess the sustainability of the 20plµs technology. From the environmental point of view, it was found that lower impacts, lower values of embodied energy and shorter energy payback times can be achieved if 20plµs technology-based PV-systems are installed.

Therefore, PV-systems applying the 20plµs technology are more environmentally sustainable than the ones applying the present industrial reference technology.

The observed beneficial effects on costs and environmental performances are only possible with a combination of cells with high efficiency and wafers with reduced thickness. Therefore, the development of industrial tools able to manufacture efficiently large volumes of $100 \mu m$ thick wafers plays a key role on the market entry and success of $20pl\mu s$ cells.

At the German site, Hanwha Q CELLS operates the Reiner-Lemoine Research Centre, including a pilot line for cell processing and a sophisticated characterization laboratory. In the R&D centre all production relevant equipment is available for all kind of cell c-Si processing. Located next to it HQC operates a production line with a cell capacity of 200 MWp. Developed new solar cell concepts and technologies can be scaled-up fast from research level to mass- production. With this setup HQC was eligible to participate in the project as industrial partner and care for the exploitation of the project outcomes.

The demonstration of pilot-production of new cell concepts within the Research Line has the following goals:

- qualification
- proof of manufacturing capability
- optimization of cell concepts and corresponding production processes

The priorities of pilot line operation are:

- Fast transfer and realization of innovations
- Base-line production of innovations for yield and process learning

In the 20plµs project, 20% efficiency was achieved in the pilot line on 100 µm thick industrially feasible c-Si solar cells. The influence of wafer thickness on the cell performance was simulated. It showed that the 20plµs pilot line cell concept is suitable for 100 to 200 µm thick wafers.

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The know how generated for the handling of thin Si wafers with a high throughput and high yield is ready for use in industrial handling systems.

The "20plus Dissemination Workshop" took place on Wednesday 24th of April at the Chambery Conference Centre Le Manage with the title "Industrially feasible processes for the next generation of high efficiency and thin crystalline silicon solar cells". This specific industry-oriented workshop was opened to the public and addressed the photovoltaic professionals. During the workshop the major 20plus EU-project results were presented. Also, external speakers were invited at the workshop.

Several scientific publications have been disseminated as listed below in section 4.2.

• **Public website**: www.20plus-pv.eu

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- [4] Z.C. Holman, A. Descoeudres, L. Barraud, F. Zicarelli, J. Seif, S. De Wolf, and C. Ballif, *Current losses at the front of silicon heterojunction solar cells*, IEEE J. Photovoltaics **2**, 7 (2012).
- [5] Z.C. Holman, M. Filipič, B. Lipovšek, S. De Wolf, F. Smole, M. Topič, and C. Ballif, *Parasitic absorption in the rear reflector of a silicon solar cell: Simulation and measurement of the sub-bandgap reflectance for common dielectric/metal reflectors*, Sol. Energy Mater. Sol. Cells **117**, 426 (2014).
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- [7] Z.C. Holman, M. Filipič, A. Descoeudres, S. De Wolf, F. Smole, M. Topič, and C. Ballif, *Long wavelength light management in high-efficiency silicon heterojunction solar cells*, J. Appl. Phys. **113**, 013107 (2013).
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4.2 Use and dissemination of foreground

In this chapter a plan for use and dissemination of foreground (including socio-economic impact and target groups for the results of the research) can be found.

The plan consists of:

Section A

This section describes the dissemination measures, including any scientific publications relating to foreground. **Its content will be made available in the public domain** thus demonstrating the added-value and positive impact of the project on the European Union.

Section B

This section specifies the exploitable foreground and provides the plans for exploitation. Information under Section B that is not marked as confidential **will be made available in the public domain** thus demonstrating the added-value and positive impact of the project on the European Union.

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Section A (public)

The following tables A1 and A2 reflect the dissemination activities in 20plus for the whole duration of the project.

Table A1: List of all scientific (peer reviewed) publications relating to the foreground of the project.

	A1: LIST OF SCIENTIFIC (PEER REVIEWED) PUBLICATIONS, STARTING WITH THE MOST IMPORTANT ONES										
NO.	Title	Main author	Title of the periodical or the series	Number, date or frequency	Publisher	Place of publication	Year of publication	Relevant pages	Permanent identifiers ¹ (if available)	Is/Will open access ² provided to this publication?	
1	Improved amorphous/crystalline silicon interface passivation by hydrogen plasma treatment	A. Descoeudres	Appl. Phys. Lett.	No 99, 2011	n.a.	n.a.	2011	n.a.	doi:10.1063/1.3641899	yes/no	
2	High-temperature stability of c- Si surface passivation by thick PECVD Al2O3 with and without hydrogenated capping layers	P. Saint-Cast	Applied Surface Science	2010					doi:10.1016/j.apsusc.20 12.03.171		
3	Variation of the layer thickness to study the electrical property of PECVD Al2O3 / c-Si interface	P. Saint-Cast	Energy Procedia	8 (2011)	Elsevier		2011	642–647			
4	High-efficiency Silicon	S. De Wolf	Green	Vol. 2 (2012)			2012	7–24			

¹ A permanent identifier should be a persistent link to the published version full text if open access or abstract if article is pay per view) or to the final manuscript accepted for publication (link to article in repository).

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² Open Access is defined as free of charge access for anyone via Internet. Please answer "yes" if the open access to the publication is already established and also if the embargo period for open access is not yet over but you intend to establish open access afterwards.

	Heterojunction Solar Cells: A Review								
5	Very fast light-induced degradation of a-Si:H/c-Si(100) interfaces	S. De Wolf	Physical Review	B 83 (2011)		2011			
6	Kinetics of a-Si:H bulk defect and a-Si:H/c-Si interface-state reduction	S. De Wolf	Physical Review	B 85 (2012)	APS	2012			
7	Improved amorphous/crystalline silicon interface passivation by hydrogen plasma treatment	A. Descoeudres	Applied Physics Letters	99, 123506 (2011)		2011			
8	Current Losses at the Front of Silicon Heterojunction Solar Cells	Z. C. Holman	IEEE Journal of Photovoltaics	VOL. 2, NO. 1, January 2012		2012			
9	Screen-Printed Al-Alloyed Rear Junction Solar Cell Concept Applied to Very Thin (100 µm) Large-Area n-Type Si Wafers	Y. Schiele	Energy Procedia	27 (2012)	Elsevier	2012	460–466	doi: 10.1016/j.egypro.2012. 07.094	Yes
10	SiliconPV Abstract Yvonne	Y. Schiele	Energy Procedia (2014) (submitted)	2014					
11	Parasitic absorption in the rear reflector of a silicon solar cell: Simulation and measurement of the sub-bandgap reflectance for common dielectric/metal reflectors	Z.C. Holman	Sol. Energy Mater. Sol. Cells	117, 2014	Elsevier	2014			
12	Scanning Laser Beam Induced Current Measurements of Lateral Transport near Junction Defects in Silicon Heterojunction Solar Cells	M.G. Deceglie	IEEE J. Photovoltaics	2013	IEEE EDS	2013			no
13	Analysis of lateral transport through inversion layer in a-Si:H / c-Si solar cells	M. Filipič	J. Appl. Phys	114, 2013	AIP	2013	074504		no
14	Record Infrared Internal	Z.C. Holman	IEEE J.	3, 2013	IEEE EDS	2013	1243		no

Tr.							_	
	Quantum Efficiency in Silicon		Photovoltaics					
	Heterojunction Solar Cells with							
	Dielectric/Metal Rear Reflectors							
15	Improving metal reflectors by	Z.C. Holman	Light: Science			2013		
10	suppressing surface plasmon	2.0.710####	& Applications			2070		
	polaritons: A priori calculation of		α Αρριισαιίστιο					
	the internal reflectance of a							
				0.0040			E400	
	solar cell			2, 2013			E106	
16	Amorphous / crystalline silicon	J. Geissbuehler	Appl. Phys. Lett		AIP	2013		no
	interface defects induced by							
	hydrogen plasma treatments			102, 2013			231604	
17	Hydrogen-doped indium	L. Barraud	Sol. Energy		Elsevier	2013		no
	oxide/indium tin oxide bilayers		Mater. Sol.					
	for high-efficiency silicon		Cells					
	heterojunction solar cells			115, 2013			151	
18	Long wavelength light	Z.C. Holman	J. Appl. Phys		AIP	2013		no
	management in high-efficiency		0.7.ppyo		,			
	silicon heterojunction solar cells			113, 2013			013107	
19	Silicon heterojunction solar cells	Α.	IEEE J.	110, 2010	IEEE EDS	2013	010101	no
19			Photovoltaics		IEEE EDS	2013		110
	on n- and p-type wafers	Descoeudres	Priotovoltaics	0.0040			00	
	compared			3, 2013			83	
20	Damage at the a-Si:H / c-Si	B. Demaurex	Appl. Phys. Lett		AIP	2012		no
	interface by indium tin oxide							
	overlayer sputtering			101, 2012			171604	
21	ENVIRONMENTAL	F.S Grasso	Proceedings of			2013		no
	SUSTAINABILITY OF HIGH		the 28th					
	EFFICIENT 100 µm THICK C-		European					
	SI SOLAR CELLS		Photovoltaic					
			Solar Energy					
			Conference and					
			Exhibition (EU					
			PVSEC) in					
			Paris (2013)					
22	Davidon mant of room nog - history	D. Mauriaan				2042	+	
22	Development of rear passivated	D. Morrison	Proceedings of			2012		no
	laser grooved buried contact		the 27th					
	(LGBC) laser fired contact		European					

23	(LFC) silicon solar cells using thin wafers Silicon heterojunction solar cells	A.	Photovoltaic Solar Energy Conference and Exhibition (EU PVSEC) in Frankfurt (2012)				2012			no
	on n- and p-type wafers with efficiencies above 20%	Descoeudres	EUPVSEC, Frankfurt, Germany	2012						
24	Investigation of wafer breakage and wafer quality for thin slurry sawn wafers	B. Weber	6th Proceedings of the International Workshop on Science and Technology of Crystalline Silicon Solar Cells	October 8-11, 2012	n.a.	n.a.	2012	4		
25	CHALLENGES OF THE MULTI WIRE SAWING PROCESS FOR THIN WAFERS BELOW 120 µm THICKNESS	B. Weber	Proceedings of the international conference held in Frankfurt, Germany	24 - 28 September 2012	WIP- Renewable Energies, 2012	n.a.	2012	pp.1060- 1063	DOI: 10.4229/27thEUPVSEC 2012-2AV.4.50	yes
26	DRAHTSÄGEPROZESSENTWI CKLUNG FÜR DIE WAFERHERSTELLUNG	B. Weber	Annual Report	2011	Fraunhofer ISE	Internet and printed reports	2011	1	http://www.ise.fraunhofe r.de/de/presse-und- medien/jahresberichte	yes
27	SLURRYBASIERTE DRAHTSÄGE¬PROZESS- ENTWICKLUNG FÜR DÜNNE WAFER	B. Weber	Annual Report	2012	Fraunhofer ISE	Internet and printed reports	2012	1	http://www.ise.fraunhofe r.de/de/presse-und- medien/jahresberichte	yes
28	SLURRY BASIERTER DRAHTSÄGEPROZESS MIT	B. Weber	Annual Report	2013	Fraunhofer ISE	Internet and printed	2013	1	http://www.ise.fraunhofe r.de/de/presse-und-	yes

П	STRUKTURIERTEN DRÄHTEN				roports			medien/jahresberichte	
		D 0 1 1 0 1			reports	0044		medien/janiesbenchte	
29	Surface Passivation of highly	P. Saint-Cast	Proceedings of			2011			no
	and lowly doped P-Type Silicon		the 26th						
	surfaces with PECVD Al2O3 for		European						
	industrially applicable solar cell		Photovoltaic						
	concepts		Solar Energy						
			Conference and						
			Exhibition (EU						
			PVSEC) in						
			Hamburg						
			(2011)						
30	21% Efficiency Silicon	A.	Proceedings of			2011			no
	Heterojunvction Solar Cells	Descoeudres	the 21st						
	produced with very high		International						
	Frequency PECVD		Photovoltaic						
	, ,		Science and						
			Engineering						
			Conference						
			November 28th						
			- December						
			2nd, 2011,						
			Fukuoka, Japan				426		
31	The European Project 20plµs:	B. Terheiden	Proceedings of			2012	0	Doi:	no
•	20 Percent Efficiency on Less	2	the 27th			-0		10.4229/27thEUPVSEC	
	Than 100 µm Thick Industrially		European					2012-2BV.6.36	
	Feasible Crystalline-Si Solar		Photovoltaic					2012 23 7:0:00	
	Cells		Solar Energy						
	Cone		Conference and						
			Exhibition (EU						
			PVSEC) in						
			Frankfurt				1586 -		
			(2012)	2012			1590		
32	Nickel Plating on p+ Silicon - A	S. Seren	Proceedings of	2012		2012	1030	Doi:	no
32	Characterization of Contact	J. Jeren	the 27th			2012		10.4229/27thEUPVSEC	110
	Resistivity and Line Resistance		European				1777 -	2012-2CV.5.52	
	Resistivity and Line Resistance		Photovoltaic	1012			1777 -	2012-20 V.O.OZ	
			Priotovoitaic	1012			1780		

			Solar Energy Conference and Exhibition (EU PVSEC) in Frankfurt (2012)						
33	Study on Boron Emitter Formation by BBr3 Diffusion for n-Type Si Solar Cell Applications	Y. Schiele	Proceedings of the 28th European Photovoltaic Solar Energy Conference and Exhibition (EU PVSEC) in Paris (2013)	2013		2013	1242 - 1247	Doi: 10.4229/ 28thEUPVSEC2013- 2BV.2.9	no
34	Electrical and Optical Analysis of Dielectric Layers for the Advanced Passivation of BBr Diffused p+ Emitters in n-Type c-Si Solar Cells	J. H. Ranzmeyer	Proceedings of the 28th European Photovoltaic Solar Energy Conference and Exhibition (EU PVSEC) in Paris (2013)	2013		2013	1367 - 1370	10.4229/28thEUPVSEC 2013-2BV.2.50	no
35	Moving beyond high open- circuit voltages in silicon heterojunction solar cells: Steps to short-circuit current densities above 39 mA/cm ²	Z.C. Holman	Proc. 39 th IEEE PVSC, Tampa, Florida	2013		2013			no
36	a-Si:H/c-Si Heterojunctions: A Future Mainstream Technology for High-Efficiency Crystalline Silicon Solar Cells?,	C. Ballif	Proc. 38th IEEE PVSC, Austin, Texas,	2012		2012			no
37	Accurate Modeling of	M. Rüdiger	Energy	8 (2011)	Elsevier	 2011	527		

	Aluminum-doped Silicon		Procedia					
38	Effect of Incomplete Ionization for the Description of Highly Aluminum-doped Silicon	M. Rüdiger	Journal of Applied Physics	110 (2011)	American Institute of Physics	2011	024508	
39	Efficiency Potential of n-type Silicon Solar Cells with Aluminum-Doped Rear p+ Emitter	M. Rüdiger	Transactions on Electron Devices	Vol. 59, No. 5	IEEE	2012	1295	
40	Microstructural and Electrical Properties of Different-sized Aluminum-alloyed Contacts and Their Layer System on Silicon Surfaces	J. Krause	Solar Energy Materials & Solar Cells	95	Elsevier	2011	2151	
41	Investigation of aluminum- alloyed local contacts for rear surface-passivated silicon solar cells	M. Rauer	Journal of Photovoltaics	Vol. 1, No. 1	IEEE	2011	22-28	no
42	Aluminum alloying in local contact areas on dielectrically passivated rear surfaces of silicon solar cells	M. Rauer	Electron Device Letters	Vol. 32, No. 7	IEEE	2011	916-918	no
43	Alloying from screen-printed aluminum pastes containing boron additives	M. Rauer	Journal of Photovoltaics	Vol. 3, No. 1	IEEE	2013	206-211	no
44	Nickel-plated front contacts for front and rear emitter silicon solar cells	M. Rauer	Energy Procedia	38	Elsevier	2013	449-458	no
45	Investigation of Aluminum- boron Doping Profiles Formed by Coalloying from Screen- printed Pastes	M. Rauer	Energy Procedia	43	Elsevier	2013	93-99	no
46	Further analysis of aluminum alloying for the formation of p+ regions in silicon solar cells	M. Rauer	Energy Procedia	8	Elsevier	2011	200-206	no
47	Incomplete ionization of aluminum in silicon and its	M. Rauer	Journal of Applied Physics	Vol. 114	AIP	2013	203702	no

Cooperation - ENERGY.2010.2.1-1
Further development of very thin wafer
based c-Si photovoltaics

Final	Report						
20plμs							

Collaborative project, IP	
Contract N° 256695	

	effect on accurate determination of doping profiles						
48	Status and Perspectives of n-	C. Schmiga	Proc. 27th	WIP-	2012		
	type Silicon Solar Cells with		EUPVSEC	Renewable			
	Aluminium-alloyed Rear Emitter			Energies		915	

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Table A2: List of all dissemination activities (publications, conferences, workshops, web sites/applications, press releases, flyers, articles published in the popular press, videos, media briefings, presentations, exhibitions, thesis, interviews, films, TV clips, posters).

			TEMPLATE A2: LIST OF DISSEMINA	ATION ACTIVITIE	S			
NO.	NO. Type of activities ³ Main leader		Title	Date/Period	Place	Type of audience ⁴	Size of audience	Countries addressed
1	20plus Dissemination Workshop (after nPV Workshop; for details see MS38)	ENI	Industrially feasible processes for the next generation of high efficiency and thin crystalline silicon solar cells	24 th April 2013	Chambery (France)	Scientific Community, Industry	49	European level
2	28th EUPVSEC, Paris, France - oral presentation	EPFL	C. Ballif: High-Efficiency Crystalline Silicon Cells Based on Heterojunction Contacts: Improving Optical Performances and Lowering Metallisation Costs	2013	Paris			
3	28th EUPVSEC, Paris, France - oral presentation	EPFL	M. Filipič: Contribution of inversion layer to lateral transport in amorphous silicon / crystalline silicon heterojunction solar cells	2013	Paris			
4	28th EUPVSEC, Paris, France - oral presentation	EPFL	J. Geissbuehler: High-efficiency silicon heterojunction solar cells with electrodeposited copper metallization	2013	Paris			
5	Silicon PV, Hameln, Germany - oral presentation	EPFL	E.M. El Mamhdi: Mestability versus irreversibility in a- Si:H degradation – Understanding passivation in high- efficiency silicon heterojunction solar cells	2013	Hameln			

^{7&}lt;sup>3</sup> A drop down list allows choosing the dissemination activity: publications, conferences, workshops, web, press releases, flyers, articles published in the popular press, videos, media b8riefings, presentations, exhibitions, thesis, interviews, films, TV clips, posters, Other.

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⁴ A drop down list allows choosing the type of public: Scientific Community (higher education, Research), Industry, Civil Society, Policy makers, Medias, Other ('multiple choices' is possible).

		T ====	1 = -		T	T	1
6	Silicon PV, Hameln - oral	EPFL	B. Demaurex: Metastability of the a-Si :H/c-Si interface	2013	Hameln		
	presentation		during silicon heterojunction solar cell fabrication				
7	Silicon PV, Hameln - oral	EPFL	Z.C. Holman: Understanding and optimizing the rear	2013	Hameln		
	presentation		internal reflectance of silicon solar cells				
8	27th EUPVSEC, Frankfurt,	EPFL	J.P. Seif: Silicon Oxide Layers for High Efficiency	2012	Frankfurt		
	Germany - oral presentation		Silicon Heterojunction Solar Cells				
9	2nd Silicon PV, Leuven.	EPFL	S. De Wolf: Light-induced degradation of a-Si:H studied	2012	Leuven		
	Belgium - oral presentation		by a-Si:H/c-Si Probes				
10	26th EUPVSEC, Hamburg,	EPFL	C. Ballif: High-efficiency silicon heterojunction solar-	2011	Hamburg		
	Germany - oral presentation		cells: From basics to pilot lines				
12	26th EUPVSEC, Hamburg,	EPFL	S. De Wolf: Very-high open-circuit voltages in silicon	2011	Hamburg		
	Germany - oral presentation		heterojunction solar cells: role of a-Si:H/c-Si interface				
			passivations				
13	1st Silicon PV conference,	EPFL	C. Ballif: High-efficiency silicon heterojunction solar-	2011	Freiburg		
	Freiburg, Germany - oral		cells: From physics to production lines				
	presentation						
14	1st Silicon PV conference,	EPFL	A. Descoeudres: Silane plasma diagnostics for high-	2011	Freiburg		
	Freiburg, Germany - oral		efficiency silicon heterojunction solar				
	presentation						
15	Presentation at the	UKON	Y. Schiele: Screen-Printed "PhosTop" Solar Cells from	2012	Falkau		
	SiliconFOREST, Falkau, Germany, March 06, 2012 - oral		< 100 µm Thick n-Type Si Wafers				
	presentation						
16	Presentation at the nPV	UKON	Y. Schiele: 19% Efficient Screen-Printed PhosTop	2012	Amsterdam		
	Workshop, Amsterdam, the		Solar Cells from 100 µm Thin n-Type Si Wafers				
	Netherlands, May 15, 2012 -						

	oral presentation						
17	20plµs Workshop, Chambéry, France, April 24, 2013 - oral presentation	UKON	Y. Schiele: 100 µm Thin All Screen Printed n-Type Solar Cells with Al Alloyed Rear Emitter	2013	Chambéry		
18	Tech. Digest 23rd PVSEC, Taipei, Taiwan - oral presentation	EPFL	A. Descoeudres: Recent progress in high-efficiency silicon heterojunction solar cells at EPFL	2013	Taipei		
19	48th MIDEM, Otočec, Slovenia - oral presentation	EPFL	M. Filipič: Analysis of parasitic light absorption losses in ITO layers at the back of Si heterojunction solar cell	2012	Otočec		
20	Tech. Digest 21st PVSEC, Fukuoka, Japan - oral presentation	EPFL	S. De Wolf: Light-induced degradation of a-Si:H studied with a-Si:H/c-Si probes	2011	Fukuoka		
21	ICANS, Toronto, Canada - oral presentation	EPFL	J. Holovský: Amorphous/Crystalline Silicon Interfaces: Correlation between Infrared Spectroscopy and Electronic Passivation Properties	2013	Toronto		
22	ICANS, Toronto, Canada - oral presentation	EPFL	S. De Wolf: High-efficiency Silicon heterojunction solar cells	2013	Toronto		
23	ICANS, Toronto, Canada - oral presentation	EPFL	J.P. Seif: Thin microcrystalline layers for application in silicon heterojunction solar cells	2013	Toronto		
24	2nd Annual Plenary FLASH meeting, Eindhoven, the Netherlands - oral presentation	EPFL	S. De Wolf: Advances in silicon heterojunction solar cells at EPFL		Eindhoven		
25	4th Workshop on Contacting Silicon Solar Cells, Konstanz,	EPFL	J. Geissbühler: Electrodeposited copper front metallization for High-efficiency silicon heterojunction	2013	Konstanz		

П	Cormany oral presentation		solar cells		<u> </u>	1	
	Germany - oral presentation		Sulai celis				
26	European Commission 20Plus Project Workshop, Chambery, France - oral presentation	EPFL	S. De Wolf: Key steps to achieving high-efficiency Silicon heterojunction solar cells on 100 µm wafers	2013	Chambéry		
27	n-PV workshop, Chambery, France - oral presentation	EPFL	Z.C. Holman: Long wavelength light management in high-efficiency silicon heterojunction solar cells	2013	Chambéry		
28	MRS 2013 Spring Meeting, San Francisco, California - oral presentation	EPFL	Z.C. Holman: Silicon nanocrystals as downshifters and microcrystalline growth templates in silicon solar cells	2013	San Francisco		
29	MRS 2013 Spring Meeting, San Francisco, California - oral presentation	EPFL	M.G. Deceglie: Lateral carrier flow near the heterointerface in amorphous/crystalline Silicon Heterojunction Solar Cells	2013	San Francisco		
30	MRS 2013 Spring Meeting, San Francisco, California, 2013 - oral presentation	EPFL	S. De Wolf: High-efficiency p- and n-type silicon heterojunction solar cells	2013	San Francisco		
31	5th International Workshop on Innovative Solar Cells, Tsukuba, Japan - oral presentation	EPFL	S. De Wolf: , Silicon photovoltaics bases on thin-film and heterojunction technology: Current status and future developments	2013	Tsukuba		
32	Korea-EU International Symposium on PV, Busan, Korea - oral presentation	EPFL	A. Descoeudres: High-efficiency silicon heterojunction solar cells and n- and p-type wafer	2012	Busan		
33	Tech. Digest 22nd PVSEC, Hangzhou, China - oral presentation	EPFL	S. De Wolf: High-efficiency p- and n-type silicon heterojunction solar cells	2012	Hangzhou		

34	TCM 2012, Crete, Greece - oral presentation	EPFL	L. Barraud: Hydrogen-doped indium oxide/indium tin oxide bilayers for high-efficiency silicon heterojunction solar cells	2012	Crete		
35	MRS 2012 Spring Meeting, San Francisco, California - oral presentation	EPFL	A. Descoeudres: Improved Amorphous/Crystalline Silicon Interface Passivation for High-efficiency Heterojunction Solar Cells	2012	San Francisco		
36	MRS 2012 Spring Meeting, San Francisco, California - oral presentation	EPFL	Z.C. Holman: Key steps to achieving high-efficiency Silicon heterojunction solar cells on 100 µm wafers	2012	San Francisco		
37	MRS 2012 Spring Meeting, San Francisco, California - oral presentation	EPFL	Z.C. Holman: Light management in silicon heterojunction solar cells	2012	San Francisco		
38	MRS 2012 Spring Meeting, San Francisco, California - oral presentation	EPFL	S. De Wolf: Staebler-Wronski Effect studied by a- Si:H/c-Si Probes	2012	San Francisco		
39	4th International Workshop on Thin-Film Silicon Solar Cells, Neuchâtel, Switzerland - oral presentation	EPFL	S. De Wolf: Properties of a-Si:H layers for silicon heterojunction solar cells	2012	Neuchâtel		
40	Plasma 2011, Kanazawa, Japan - oral presentation	EPFL	S. De Wolf: Plasma diagnostics for high-efficiency silicon heterojunction solar cells	2011	Kanazawa		
41	Plasma 2011, Kanazawa, Japan - oral presentation	EPFL	S. De Wolf: Plasma diagnostics for high-efficiency silicon heterojunction solar cells	2011	Kanazawa		
42	SUNday 2011, Utrecht, the Netherlands - oral presentation	EPFL	S. De Wolf: Amorphous / crystalline silicon heterojunction solar-cells	2011	Utrecht		

43	MRS 2011 Spring Meeting, San Francisco, California - oral presentation	Francisco, California - oral interfaces		2011	San Francisco	
44	MRS 2011 Spring Meeting, San Francisco, California - oral presentation	EPFL	S. De Wolf: Nature of intrinsic a-Si:H/c-Si interface passivation	2011	San Francisco	
45	7th Workshop on the Future Direction of Photovoltaics, Tokyo, Japan - oral presentation	EPFL	S. De Wolf: High-efficiency silicon heterojunction solar- cells: From physics to production lines	2011	Tokyo	
46	20plµs Workshop, Chambéry, France, April 24, 2013 - oral presentation	ENI	F. Sebastiano Grasso: Environmental sustainability of high industrially feasible c-Si solar cells	2013	Chambéry	
47	20plµs Workshop, Chambéry, France, April 24, 2013 - oral presentation	HQC	T. Ballmann: Transfer of the 20plus high efficiency cell structure into pilot line production	2013	Chambéry	
48	20plµs Workshop, Chambéry, France, April 24, 2013 - oral presentation	ISE	C. Schmiga: n-type Silicon Solar Cells with Local Aluminium-alloyed Emitters by Applying the p-type PERC Fabrication Process	2013	Chambéry	
49	20plµs Workshop, Chambéry, France, April 24, 2013 - oral presentation	SCT	D. J. Morrison: Fabrication of Laser Grooved Buried Contact Silicon Solar Cells	2013	Chambéry	
50	20plµs Workshop, Chambéry, France, April 24, 2013 - oral presentation	EPFL	S. De Wolf: Key steps to achieving high-efficiency Silicon heterojunction solar cells on 100 µm wafers	2013	Chambéry	
51	20plµs Workshop, Chambéry,	EPFL	B. Michl: Efficiency Limiting Bulk Recombination	2013	Chambéry	

presentation		Analysis ELBA Applied to Thin Solar Cells					
20plµs Workshop, Chambéry, France, April 24, 2013 - oral presentation	ISE	B. Weber: Challenges in Wafering of Thin Silicon Wafers ≤120 μm	2013	Chambéry			
27th EUPVSEC, Frankfurt, Germany - oral presentation	ISE	C. Schmiga: Status and Perspectives of n-type Silicon Solar Cells with Aluminium-alloyed Rear Emitter	2012	Frankfurt			
1st nPV Workshop, Konstanz, Germany – oral presentation	ISE	C. Schmiga: Aluminium-alloyed Emitters for n-type Silicon Solar Cells	2011	Konstanz			
37th IEEE PVSC, Seattle, USA, June 2011 – oral presentation	ISE	M. Rauer: Investigation of Aluminum-alloyed Local Contacts for Rear Surface-passivated Silicon Solar Cells	2011	Seattle			
2nd nPV Workshop, Amsterdam, The Netherlands - oral presentation	ISE	M. Rauer: Alloying of Screen-printed Aluminum Pastes Containing Boron Additives	2012	Amsterdam			
4th Metallization Workshop, Konstanz, Germany - oral presentation	ISE	M. Rauer: Investigation of Aluminum-boron Doping Profiles Formed by Coalloying of Screen-printed Pastes	2013	Konstanz			
	France, April 24, 2013 - oral presentation 27th EUPVSEC, Frankfurt, Germany - oral presentation 1st nPV Workshop, Konstanz, Germany – oral presentation 37th IEEE PVSC, Seattle, USA, June 2011 – oral presentation 2nd nPV Workshop, Amsterdam, The Netherlands - oral presentation 4th Metallization Workshop, Konstanz, Germany - oral	France, April 24, 2013 - oral presentation 27th EUPVSEC, Frankfurt, Germany - oral presentation 1st nPV Workshop, Konstanz, Germany - oral presentation 37th IEEE PVSC, Seattle, USA, June 2011 - oral presentation 2nd nPV Workshop, Amsterdam, The Netherlands - oral presentation 4th Metallization Workshop, Konstanz, Germany - oral	France, April 24, 2013 - oral presentation Wafers ≤120 μm 27th EUPVSEC, Frankfurt, Germany - oral presentation ISE C. Schmiga: Status and Perspectives of n-type Silicon Solar Cells with Aluminium-alloyed Rear Emitter 1st nPV Workshop, Konstanz, Germany - oral presentation ISE C. Schmiga: Aluminium-alloyed Emitters for n-type Silicon Solar Cells 37th IEEE PVSC, Seattle, USA, June 2011 - oral presentation ISE M. Rauer: Investigation of Aluminum-alloyed Local Contacts for Rear Surface-passivated Silicon Solar Cells 2nd nPV Workshop, Amsterdam, The Netherlands - oral presentation ISE M. Rauer: Alloying of Screen-printed Aluminum Pastes Containing Boron Additives 4th Metallization Workshop, Konstanz, Germany - oral ISE M. Rauer: Investigation of Aluminum-boron Doping Profiles Formed by Coalloying of Screen-printed Pastes	France, April 24, 2013 - oral presentation Wafers ≤120 μm 27th EUPVSEC, Frankfurt, Germany - oral presentation ISE C. Schmiga: Status and Perspectives of n-type Silicon Solar Cells with Aluminium-alloyed Rear Emitter 2012 1st nPV Workshop, Konstanz, Germany - oral presentation ISE C. Schmiga: Aluminium-alloyed Emitters for n-type Silicon Solar Cells 2011 37th IEEE PVSC, Seattle, USA, June 2011 - oral presentation ISE M. Rauer: Investigation of Aluminum-alloyed Local Contacts for Rear Surface-passivated Silicon Solar Cells 2011 2nd nPV Workshop, Amsterdam, The Netherlands - oral presentation ISE M. Rauer: Alloying of Screen-printed Aluminum Pastes Containing Boron Additives 2012 4th Metallization Workshop, Konstanz, Germany - oral ISE M. Rauer: Investigation of Aluminum-boron Doping Profiles Formed by Coalloying of Screen-printed Pastes 2013	France, April 24, 2013 - oral presentation Wafers ≤120 μm 27th EUPVSEC, Frankfurt, Germany - oral presentation ISE C. Schmiga: Status and Perspectives of n-type Silicon Solar Cells with Aluminium-alloyed Rear Emitter 2012 Frankfurt 1st nPV Workshop, Konstanz, Germany - oral presentation ISE C. Schmiga: Aluminium-alloyed Emitters for n-type 2011 Konstanz 37th IEEE PVSC, Seattle, USA, June 2011 - oral presentation ISE M. Rauer: Investigation of Aluminum-alloyed Local Contacts for Rear Surface-passivated Silicon Solar Cells 2011 Seattle 2nd nPV Workshop, Amsterdam, The Netherlands - oral presentation ISE M. Rauer: Alloying of Screen-printed Aluminum Pastes Containing Boron Additives 2012 Amsterdam 4th Metallization Workshop, Konstanz, Germany - oral ISE M. Rauer: Investigation of Aluminum-boron Doping Profiles Formed by Coalloying of Screen-printed Pastes 2013 Konstanz	France, April 24, 2013 - oral presentation 27th EUPVSEC, Frankfurt, Germany - oral presentation ISE C. Schmiga: Status and Perspectives of n-type Silicon Solar Cells with Aluminium-alloyed Rear Emitter 1st nPV Workshop, Konstanz, Germany - oral presentation ISE C. Schmiga: Aluminium-alloyed Emitters for n-type Silicon Solar Cells C. Schmiga: Aluminium-alloyed Emitters for n-type Silicon Solar Cells M. Rauer: Investigation of Aluminum-alloyed Local Contacts for Rear Surface-passivated Silicon Solar Cells Contacts for Rear Surface-passivated Silicon Solar Cells M. Rauer: Alloying of Screen-printed Aluminum Pastes Containing Boron Additives M. Rauer: Investigation of Aluminum Pastes Containing Boron Additives M. Rauer: Investigation of Aluminum-boron Doping Profiles Formed by Coalloying of Screen-printed Pastes	France, April 24, 2013 - oral presentation Wafers ≤120 μm 27th EUPVSEC, Frankfurt, Germany - oral presentation ISE C. Schmiga: Status and Perspectives of n-type Silicon Solar Cells with Aluminium-alloyed Rear Emitter 1st nPV Workshop, Konstanz, Germany - oral presentation ISE C. Schmiga: Aluminium-alloyed Emitters for n-type Silicon Solar Cells C. Schmiga: Aluminium-alloyed Emitters for n-type Silicon Solar Cells M. Rauer: Investigation of Aluminum-alloyed Local Contacts for Rear Surface-passivated Silicon Solar Cells M. Rauer: Alloying of Screen-printed Aluminum Pastes Containing Boron Additives The Netherlands - oral presentation Wafers ≤120 μm Wafers ≤120 μm Frankfurt C. Schmiga: Status and Perspectives of n-type Silicon Solar Cells Wonstanz M. Konstanz M. Rauer: Investigation of Aluminum-Boron Doping Profiles Formed by Coalloying of Screen-printed Pastes M. Rauer: Investigation of Aluminum-Boron Doping Profiles Formed by Coalloying of Screen-printed Pastes

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Section B (Confidential 5 or public: confidential information to be marked clearly) Part B1

There were no applications for patents, trademarks, registered designs.

Part B2

The following Table B2 specify the exploitable foreground.

Table B2: Exploitable Foreground. If the 3rd column is marked with "Yes", the content is confidential and may NOT be made public).

Type of Exploitable Foreground ⁶	Description of exploitable foreground	Confidential Click on YES/NO	Foreseen embargo date dd/mm/yyyy	Exploitable product(s) or measure(s)	Sector(s) of application ⁷	Timetable, commercial or any other use	Patents or other IPR exploitation (licences)	Owner & Other Beneficiary(s) involved
General advancement of knowledge	Properties of boron etch back emitter	Yes		Knowledge	Silicon solar cell processing			UKON
General advancement of knowledge	Ni plating on p+-doped Si layers	Yes		Knowledge	Silicon solar cell processing			UKON
General advancement of knowledge	Handling of thin large area mono- and multicrystalline Si wafers.	Yes		Knowledge	Silicon solar cell processing			UKON
GENERAL ADVANCEMENT OF	Development for ultra- high Voc cells, with	Yes		Increased know- how	Silicon solar cell processing;			EPFL

⁵ Note to be confused with the "EU CONFIDENTIAL" classification for some security research projects.

¹⁹ A drop down list allows choosing the type of foreground: General advancement of knowledge, Commercial exploitation of R&D results, Exploitation of R&D results via standards, exploitation of results through EU policies, exploitation of results through (social) innovation.

⁷ A drop down list allows choosing the type sector (NACE nomenclature): http://ec.europa.eu/competition/mergers/cases/index/nace_all.html
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Type of Exploitable Foreground ⁶	Description of exploitable foreground	Confidential Click on YES/NO	Foreseen embargo date dd/mm/yyyy	Exploitable product(s) or measure(s)	Sector(s) of application ⁷	Timetable, commercial or any other use	Patents or other IPR exploitation (licences)	Owner & Other Beneficiary(s) involved
KNOWLEGDE	processes allowing close to 750 mV				PV industry			
GENERAL ADVANCEMENT OF KNOWLEGDE	Handling of thin wafers, and control of parasitic absorption	Yes		Increased knowledge	Silicon solar cell processing; possibly semiconductor industry			EPFL
GENERAL ADVANCEMENT OF KNOWLEGDE	Cells with controllolabe T coefficient	Yes		Process know- how	Silicon solar cell processing; PV industry			EPFL
GENERAL ADVANCEMENT OF KNOWLEGDE	With the help of the 20plus project there is also currently strong general industrial interest for such n-type technology in Europe	Yes		Better link between Research Institute and Industry	PV industry			EPFL
General advancement of knowledge	Advanced sawing process development using structured wires	No		Knowledge	Silicon solar cell processing; possibly semiconductor industry			Fraunhofer ISE
General advancement of knowledge	Efliciency Limiting Bulk Recombination Analysis (ELBA) Tool	No		Knowledge; Service measurements at ISE	Sliicon Material Characterisation	As of now		Fraunhofer ISE
General advancement of knowledge	Advanced layers for passivation of silicon surfaces	No		Knowledge	Silicon solar cell processing			Fraunhofer ISE
General advancement of knowledge	Advanced metallisation pastes for Al-alloyed contacts	No		Knowledge	Silicon solar cell processing			Fraunhofer ISE
Exploitation of	Handling prototype for	Yes		Technology can	Silicon solar cell			MST

Exploitable Foreground ⁶	of exploitable foreground	Click on YES/NO	embargo date dd/mm/yyyy	Exploitable product(s) or measure(s)	Sector(s) of application ⁷	Timetable, commercial or any other use	other IPR exploitation (licences)	Owner & Other Beneficiary(s) involved
innovation wafe 100µ high	e side contactless fer handling of min. Oum thin wafer with h yield successfully monstrated			be adapted in different handling stations, where problems with current technologies occurs	processing; possibly semiconductor industry			

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Partners Hanwha Q Cells and ENI provided additional explanations about the exploitable foreground (CONFIDENTIAL):

HQC (confidential)

• Exploitation of results

At the German site, Hanwha Q CELLS operates the Reiner-Lemoine Research Centre, including a pilot line for cell processing and a sophisticated characterization laboratory. In the R&D centre all production relevant equipment is available for all kind of cell c-Si processing. Located next to it HQC operates a production line with a cell capacity of 200 MWp. Developed new solar cell concepts and technologies can be scaled-up fast from research level to mass- production.



With this setup HQC was eligible to participate in the project as industrial partner and care for the exploitation of the project outcomes.

The demonstration of pilot-production of new cell concepts within the Research Line has the following goals:

- qualification
- proof of manufacturing capability
- Optimization of cell concepts and corresponding production processes

The priorities of pilot line operation are:

- Fast transfer and realization of innovations
- Base-line production of innovations for yield and process learning

In the 20plµs project, 20% efficiency was achieved in the pilot line on 100 µm thick industrially feasible c-Si solar cells. The influence of wafer thickness on the cell performance was simulated. It showed that the 20plµs pilot line cell concept is suitable for 100 to 200 µm thick wafers.

These valuable results are industrially feasible and stabilize and establish technological leadership of HQC and thus sustain the company site with 750 employees in Germany in the long term.

At the current market situation, thin wafers are not demanded because of the strong decrease of Simaterial costs within the last years. Hence thin wafers will not be implemented at the moment to the production of Hanwha Q CELLS. However, HQC is able to respond quickly to changes in wafer supply or market situation, based on the good results of the 20plµs project.

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ENI (confidential)

Within the 20plus project significant attention was paid to socio-environmental-economic aspects.

First of all the 20plus technology was analyzed from the technological point of view and the scalability to pilot line production was assessed. Within the investigated technologies, the PHT process turned out to be the readiest for a possible inline implementation, due to process high compatibility with module integration. Within the project, it was shown that it is possible to manufacture high efficient solar cells out of silicon wafers with 120um starting thickness. In terms of costs, it was found that processing cells with reduced thickness and enhanced performances can potentially bring about a lowering of the manufacturing costs (€/Wp). The adoption of thinner wafers turned out to play a relevant role. In fact, a lower use of silicon per wafer can lead to a higher exploitation of ingots.

If further technological enhancements can be achieved and the manufacturing process can be targeted to mass production volumes, 20plus devices can be proposed as potential breakthrough technologies, capable of lowering down the production costs. Further beneficial effects on costs are expected with the adoption of an integrated fab (silicon manufacturing, wafering, cells processing and module assembling) integrating the recycling of by-products and wastes.

Then, all the aspects above can act as driving force in the lowering of the PV-generated kWh cost and ultimately target the spread out of PV-systems to reach a broader distributed electricity generation scenario in the EU.

On the environmental side, a life cycle analysis was performed to assess the sustainability of the 20 plus technology. For PV-devices/systems, typically life cycle analyses are focused on the calculation of GWP impacts and EPBT. Instead, within the 20 plus project, we tried to depict a wider and detailed picture of the impacts. According to the EDIP methodology, in total ten different impact categories were investigated for each single manufacturing step of the 20 plus process flows. Such extended assessment led to the identification of the impacts on water, air and soil. Besides, such approach allowed us to identify the critical steps and suggest on what steps to pay attention, should it be developed a more environmentally friendly process.

From the environmental point of view, it was found that lower impacts, lower values of embodied energy and shorter energy payback times can be achieved if 20plus technology-based PV-systems are installed.

Therefore, PV-systems applying the 20plus technology are more environmentally sustainable than the ones applying the present industrial reference technology.

The observed beneficial effects on costs and environmental performances are only possible with a combination of cells with high efficiency and wafers with reduced thickness. Therefore, the

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development of industrial tools able to manufacture efficiently large volumes of 120um thick wafers plays a key role on the market entry and success of 20plus cells.

All the major results and the considerations discussed herein were disseminated to PV-professionals and PV-industries during the 20plµs Workshop held on 24th of April 2013 in Chambéry (France) with the title "Industrially feasible processes for the next generation of high efficiency and thin crystalline silicon solar cells".

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4.3 Report on societal implications

Replies to the following questions will assist the Commission to obtain statistics and indicators on societal and socio-economic issues addressed by projects. The questions are arranged in a number of key themes. As well as producing certain statistics, the replies will also help identify those projects that have shown a real engagement with wider societal issues, and thereby identify interesting approaches to these issues and best practices. The replies for individual projects will not be made public.

A	General Information (completed a entered.	nutomatically when Grant Agreement number	is				
Grai	nt Agreement Number:						
Gra	nt rigitement rumber.	256695					
Title	of Project:	20plµs					
Nam	Name and Title of Coordinator: Dr. Barbara Terheiden						
В	Ethics						
1. D	id your project undergo an Ethics Review (and	l/or Screening)?					
		progress of compliance with the relevant Ethics frame of the periodic/final project reports?	0Yes XNo				
	Special Reminder: the progress of compliance with the Ethics Review/Screening Requirements should be described in the Period/Final Project Reports under the Section 3.2.2 'Work Progress and Achievements'						
2. box		involved any of the following issues (tick					
RES	EARCH ON HUMANS		•				
•	Did the project involve children?						
•	Did the project involve patients?						
•	Did the project involve persons not able to give	consent?					
•	Did the project involve adult healthy volunteers?	?					
•	Did the project involve Human genetic material?	?					
•	Did the project involve Human biological sampl	es?					
•	Did the project involve Human data collection?						
RES	EARCH ON HUMAN EMBRYO/FOETUS						
•	Did the project involve Human Embryos?						
•	Did the project involve Human Foetal Tissue / C	Cells?					
•	Did the project involve Human Embryonic Stem	Cells (hESCs)?					
•	Did the project on human Embryonic Stem Cells	s involve cells in culture?					
•	Did the project on human Embryonic Stem Cells	s involve the derivation of cells from Embryos?					
Priv	VACY						
	 Did the project involve processing of gene lifestyle, ethnicity, political opinion, religiou 	etic information or personal data (eg. health, sexual s or philosophical conviction)?					
	• Did the project involve tracking the location	or observation of people?					
RES	EARCH ON ANIMALS						
	Did the project involve research on animals?						

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Were those animals transgenic small laboratory animals?	
Were those animals transgenic farm animals?	
Were those animals cloned farm animals?	
Were those animals non-human primates?	
RESEARCH INVOLVING DEVELOPING COUNTRIES	
• Did the project involve the use of local resources (genetic, animal, plant etc)?	
Was the project of benefit to local community (capacity building, access to healthcare, education	
etc)?	
DUAL USE	
Research having direct military use	0 Yes 0 No
Research having the potential for terrorist abuse	

C Workforce Statistics

3. Workforce statistics for the project: Please indicate in the table below the number of people who worked on the project (on a headcount basis).

Type of Position	Number of Women	Number of Men
Scientific Coordinator	1	
Work package leaders	3	4
Experienced researchers (i.e. PhD holders)	8	14
PhD Students	3	4
Other	8	22

4. How many additional researchers (in companies and universities) were recruited specifically for this project?	5
Of which, indicate the number of men:	1

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D	Candan	A am a ata								
	Gender A		101 0 1 1	70. A			X7			
5.	Did you	carry out spec	cific Gender Equa	ality Action	s under the project?	0	Yes No			
6.	Which of the following actions did you carry out and how effective were they?									
	Not at all Very									
		Design and imple	ement an equal onnort	unity policy		effective				
		-	ences and workshops of		0000					
			ve work-life balance	8	0000	_				
	X	Other:		ite we provide	ed a link to the European Plat		nen Scientists			
7.	Was there a gender dimension associated with the research content – i.e. wherever people were the focus of the research as, for example, consumers, users, patients or in trials, was the issue of gender considered and addressed? O Yes- please specify X No									
E	Synergi	ies with Scier	nce Education							
	X	participation in science festivals and events, prizes/competitions or joint projects)? X Yes- please specify: UKON: 2 Pupils joined for a day, 1 Bachelor and 1 Master thesis were conducted, about 5 students joined to learn scientific working, BoGy (practical training for about 3 pupils to get first job orientation) ISE: girls science day; BoGY Praktika (practical training for about 36 pupils to get first job orientation)								
	O No									
9.	booklets	, DVDs)?	·	cation mat	erial (e.g. kits, website	es, explan	natory			
	0	Yes- please spec	ify							
	X	No				•				
F	Interdi	sciplinarity								
10.	Which d	lisciplines (see l	list below) are inv	volved in v	our project?					
	X	Main discipline ⁸	· · · · · · · · · · · · · · · · · · ·	•						
	0	Associated discip		0	Associated discipline ⁸ :					
G	Engagi	ng with Civil	society and po	olicy mak	ers					
11a	Did vo	our project eng	gage with societal	actors bev	ond the research	0	Yes			
	•	inity? (if 'No' ac	, 0	J		X	No			

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⁸ Insert number from list below (Frascati Manual).

11b	11b If yes, did you engage with citizens (citizens' panels / juries) or organised civil society (NGOs, patients' groups etc.)?									
	0	O No								
	0	Yes- in determining what research should be performed								
	0	Yes - in implementing the research								
	O Yes, in communicating /disseminating / using the results of the project									
11c	11c In doing so, did your project involve actors whose role is mainly to organise the dialogue with citizens and organised civil society (e.g. professional mediator; communication company, science museums)?									
12.	Did you o organisat	~ ~	government / public bodies	or pol	icy makers (includi	ng inter	national			
	0	No								
	0	Yes- in fram	ing the research agenda							
	0	Yes - in implementing the research agenda								
	0									
13a	Will the project generate outputs (expertise or scientific advice) which could be used by policy makers? Yes – as a primary objective (please indicate areas below-multiple answers possible) Yes – as a secondary objective (please indicate areas below - multiple answer possible) No									
13b	If Yes, in	which field	s?							
Budget Compe Consur Culture Custon Develo Moneta Educat	visual and Medi t etition mers e	iic and Youth	Energy Enlargement Enterprise Environment External Relations External Trade Fisheries and Maritime Affairs Food Safety Foreign and Security Policy Fraud Humanitarian aid		Human rights Information Society Institutional affairs Internal Market Justice, freedom and securit Public Health Regional Policy Research and Innovation Space Taxation Transport	y				

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13c If Yes, at which level?										
C	Local / regional levels									
C										
C	-									
С	International level									
H Use a	H Use and dissemination									
14. How m	48	48								
To how man	y of these is open access ⁹ provided?	•			currently under process					
How many	of these are published in open access jour	nals?								
How many	of these are published in open repositories	s?								
To how man	y of these is open access not provide	ed?								
Please che	ck all applicable reasons for not providing	open a	ccess:							
	r's licensing agreement would not permit publ	lishing	in a rep	oository						
	ole repository available ole open access journal available									
	s available to publish in an open access journa	ıl								
	ime and resources									
other ¹⁰ :	nformation on open access									
	nany new patent applications ('prior	rity fil	lings,	have been made	Δ?	None				
	ologically unique": multiple applications for t				C •	None				
	ions should be counted as just one application			33						
	te how many of the following Intelle			Trademark	0					
Proper each b	ty Rights were applied for (give numox).	mber	ın	Registered design	0					
	Other	0								
17. How m		None								
Indicate the approximate number of additional jobs in these compo										
18. Please i										
	e situation before your project has a	poten	itiai ii	iipact on employ	шсп	t, in comparison				
☐ Increase in employment, or ☐ ☐ In small & medium-sized enterprises										
	rease in employment,	X	None	of the above / not rea	levant	to the project				
X Difficult to estimate / not possible to quantify										

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 $^{^9}$ Open Access is defined as free of charge access for anyone via Internet. 10 For instance: classification for security project.

Indicate figure: 19. For your project partnership please estimate the employment effect resulting directly from your participation in Full Time Equivalent (FTE = one person working fulltime for a year) jobs: Difficult to estimate / not possible to quantify Media and Communication to the general public I 20. As part of the project, were any of the beneficiaries professionals in communication or media relations? Yes (Werner Warmuth, PSE) 21. As part of the project, have any beneficiaries received professional media / communication training / advice to improve communication with the general public? Yes No 0 X 22 Which of the following have been used to communicate information about your project to the general public, or have resulted from your project? Press Release Coverage in specialist press Media briefing Coverage in general (non-specialist) press TV coverage / report Coverage in national press Radio coverage / report Coverage in international press Brochures /posters / flyers Website for the general public / internet X DVD /Film /Multimedia Event targeting general public (festival, conference, exhibition, science café) In which languages are the information products for the general public produced? 23 Language of the coordinator English

Question F-10: Classification of Scientific Disciplines according to the Frascati Manual 2002 (Proposed Standard Practice for Surveys on Research and Experimental Development, OECD 2002):

FIELDS OF SCIENCE AND TECHNOLOGY

Other language(s)

1. NATURAL SCIENCES

- 1.1 Mathematics and computer sciences [mathematics and other allied fields: computer sciences and other allied subjects (software development only; hardware development should be classified in the engineering fields)]
- 1.2 Physical sciences (astronomy and space sciences, physics and other allied subjects)
- 1.3 Chemical sciences (chemistry, other allied subjects)
- 1.4 Earth and related environmental sciences (geology, geophysics, mineralogy, physical geography and other geosciences, meteorology and other atmospheric sciences including climatic research, oceanography, vulcanology, palaeoecology, other allied sciences)
- 1.5 Biological sciences (biology, botany, bacteriology, microbiology, zoology, entomology, genetics, biochemistry, biophysics, other allied sciences, excluding clinical and veterinary sciences)

2 ENGINEERING AND TECHNOLOGY

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- 2.1 Civil engineering (architecture engineering, building science and engineering, construction engineering, municipal and structural engineering and other allied subjects)
- 2.2 Electrical engineering, electronics [electrical engineering, electronics, communication engineering and systems, computer engineering (hardware only) and other allied subjects]
- 2.3. Other engineering sciences (such as chemical, aeronautical and space, mechanical, metallurgical and materials engineering, and their specialised subdivisions; forest products; applied sciences such as geodesy, industrial chemistry, etc.; the science and technology of food production; specialised technologies of interdisciplinary fields, e.g. systems analysis, metallurgy, mining, textile technology and other applied subjects)

3. MEDICAL SCIENCES

- 3.1 Basic medicine (anatomy, cytology, physiology, genetics, pharmacy, pharmacology, toxicology, immunology and immunohaematology, clinical chemistry, clinical microbiology, pathology)
- 3.2 Clinical medicine (anaesthesiology, paediatrics, obstetrics and gynaecology, internal medicine, surgery, dentistry, neurology, psychiatry, radiology, therapeutics, otorhinolaryngology, ophthalmology)
- 3.3 Health sciences (public health services, social medicine, hygiene, nursing, epidemiology)

4. AGRICULTURAL SCIENCES

- 4.1 Agriculture, forestry, fisheries and allied sciences (agronomy, animal husbandry, fisheries, forestry, horticulture, other allied subjects)
- 4.2 Veterinary medicine

5. SOCIAL SCIENCES

- 5.1 Psychology
- 5.2 Economics
- 5.3 Educational sciences (education and training and other allied subjects)
- Other social sciences [anthropology (social and cultural) and ethnology, demography, geography (human, economic and social), town and country planning, management, law, linguistics, political sciences, sociology, organisation and methods, miscellaneous social sciences and interdisciplinary, methodological and historical S1T activities relating to subjects in this group. Physical anthropology, physical geography and psychophysiology should normally be classified with the natural sciences].

6. HUMANITIES

- 6.1 History (history, prehistory and history, together with auxiliary historical disciplines such as archaeology, numismatics, palaeography, genealogy, etc.)
- 6.2 Languages and literature (ancient and modern)
- 6.3 Other humanities [philosophy (including the history of science and technology) arts, history of art, art criticism, painting, sculpture, musicology, dramatic art excluding artistic "research" of any kind, religion, theology, other fields and subjects pertaining to the humanities, methodological, historical and other S1T activities relating to the subjects in this group]

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